

U.S. UTILITY Patent Application

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APPL NUM	FILING DATE	CLASS	SUBCLASS	GAU	EXAMINER	
10007384	10/22/2001	438 /	401	2812	TAN TRAN	
**APPLICANT	'S· Nishiha	Eiii: Kiku	chi Shuichi;		· · · · · · · · · · · · · · · · · · ·	
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Foreign priority clai		15 yes			ATTORNEY DOCKET NO	
35 USC 119 conditions met				10417-103001		
Verified and Acknowledged Examiners's initials 10417-103001 TITLE: Semiconductor device and manufacturing method thereof						
. Semico		manuia	Adming memor	4161601	U.S.DEPT, OF COMM./PAT.& TM-PTO-436L(Rev. 12-94	

NOTICE OF ALLOWANCE MAILED			CLAIMS ALLOWED					
		Assistant Examiner	Total Claims		Print Claim for O.G			
ISSUE FEE			DRAWING					
Amount Due	Date Paid		Sheets Drug.	Figs.Dr	wg.	Print Fig.		
		Primary Examiner		<u> </u>		<u> </u>		
TERMINAL		PREPARED FOR ISSUE	Application Examiner					
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